

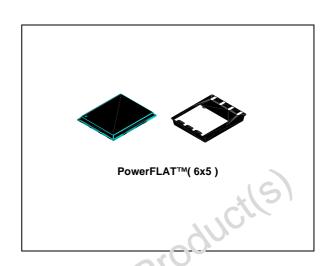
## STL100NH3LL

# N-channel 30 V - 0.0032 Ω - 25 A - PowerFLAT™ (6x5) STripFET™ III Power MOSFET

### **Features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STL100NH3LL	30 V	<0.0035 Ω	25A <sup>(1)</sup>

- 1. The value is rated according  $R_{thj\text{-pcb}}$
- Improved die-to-footprint ratio
- Very low profile package (1 mm max)
- Very low thermal resistance
- Conduction losses reduced
- Switching losses reduced



### **Application**

■ Switching applications

### **Description**

This series utilizes the last advanced design rules of ST's proprietary STripFET<sup>TM</sup> technology. This process complete to unique metallization technique realised the most advanced low coltage Power MOSFET in PowerFLAT<sup>TM</sup> (6×5, The chipscaled PowerFLAT<sup>TM</sup> package allows a significant board space saving, still boosting the performance.

Figure 1. In crnal schematic diagram

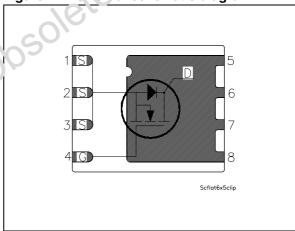


Table Device summary

Order code	Marking	Package	Packaging
STL100NH3LL	L100NH3LL	PowerFLAT™ (6x5)	Tape and reel

March 2008 Rev 11 1/12

Contents STL100NH3LL

### **Contents**

1	Electrical ratings 3
2	Electrical characteristics 4
	2.1 Electrical characteristics (curves)
3	Test circuit 8
4	Package mechanical data
5	Revision history11
Obsol	Revision history



STL100NH3LL **Electrical ratings** 

# **Electrical ratings**

Table 2. **Absolute maximum ratings** 

Symbol	Parameter	Value	Unit		
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	30	V		
V <sub>GS</sub> <sup>(1)</sup>	Gate-source voltage	± 16	V		
V <sub>GS</sub> <sup>(2)</sup>	Gate-source voltage	± 18	V		
I <sub>D</sub> (3)	Drain current (continuous) at T <sub>C</sub> = 25 °C	100	Α		
I <sub>D</sub> <sup>(3)</sup>	Drain current (continuous) at T <sub>C</sub> = 100 °C	71	Α		
I <sub>D</sub> <sup>(5)</sup>	Drain current (continuous) at T <sub>C</sub> =100 °C 15.6				
I <sub>DM</sub> <sup>(4)</sup>	Drain current (pulsed)	100	Α		
I <sub>D</sub> <sup>(5)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C 25				
P <sub>TOT</sub> (3)	Total dissipation at T <sub>C</sub> = 25 °C	80	W		
P <sub>TOT</sub> (5)	Total dissipation at T <sub>C</sub> = 25 °C	4	W		
	Derating factor	0.03	W/°C		
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 150	°C		
<ol> <li>The value</li> <li>Pulse width</li> </ol>	s mode d for test time ≤15ms is rated according R <sub>thj-c</sub> h limited by safe operating area is rated according R <sub>thi-pcb</sub>				

- 1. Continuous mode
- 2. Guaranteed for test time ≤15ms
- 3. The value is rated according  $R_{\mbox{\scriptsize thj-c}}$
- 4. Pulse width limited by safe operating area
- 5. The value is rated according  $R_{thj\text{-pcb}}$

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case (drain) (steady state)	1.56	°C/W
R <sub>thj-pcb</sub> (1)	Thermal resistance junction-ambient	31.3	°C/W

<sup>1.</sup> When mounted on FR-4 board of 1inch², 2oz Cu, t < 10 sec

Avalanche data

0	10	nted on FR-4 board of 1inch², 2oz Cu, t < 10 sec  Avalanche data		
050	Symbol	Parameter	Value	Unit
,	I <sub>AV</sub>	Not-repetitive avalanche current	7.5	Α
	E <sub>AS</sub>	Single pulse avalanche energy (starting T <sub>J</sub> =25 °C, I <sub>D</sub> =7.5 A)	150	mJ

**Electrical characteristics** STL100NH3LL

#### **Electrical characteristics** 2

(T<sub>CASE</sub>=25°C unless otherwise specified)

On/off states Table 5.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	30			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	$V_{DS}$ = Max rating, $V_{DS}$ = Max rating @125 °C			1 10	μ <b>Α</b> μ <b>Α</b>
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±16 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		2.5	٧
R <sub>DS(on)</sub>	Static drain-source on resistance	$V_{GS}$ = 10 V, $I_{D}$ = 12.5 A $V_{GS}$ = 4.5 V, $I_{D}$ = 12.5 A		0.0032 0.004	0.0035 0.005	$\Omega$

Table 6. **Dynamic** 

	Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
	g <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	V <sub>DS</sub> =10 V, I <sub>D</sub> = 12.5 A		30		S
	C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> =25 V, f=1 MHz, V <sub>GS</sub> =0		4450 655 50		pF pF pF
	Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD}$ =15 V, $I_{D}$ = 25 A $V_{GS}$ =4.5 V (see Figure 8)		30 12.5 10	40	nC nC nC
	R <sub>G</sub>	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain	1	2	3	Ω
Obsole	1. Pulsed:	oulse duration=300 μs, duty cycle	1.5%				

STL100NH3LL **Electrical characteristics** 

Table 7. **Switching times** 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 15 \text{ V}, I_{D} = 12.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 14)		18 50 75 8		ns ns ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
$I_{SD}$	Source-drain current				25	Α
$I_{\text{SDM}}^{(1)}$	Source-drain current (pulsed)				100	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> =25 A, V <sub>GS</sub> =0			1.3	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> =25 A,		32	4/5	ns
$Q_{rr}$	Reverse recovery charge	di/dt = 100 A/µs,		34		nC ^
I <sub>RRM</sub>	Reverse recovery current	V <sub>DD</sub> =25 V, Tj=150 °C		2.1		Α
ie P	roduci(s)	josoleite P				



STL100NH3LL **Electrical characteristics** 

#### **Electrical characteristics (curves)** 2.1

Figure 2. Safe operating area

Figure 3. Thermal impedance

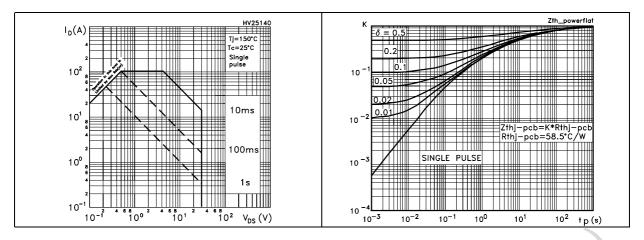
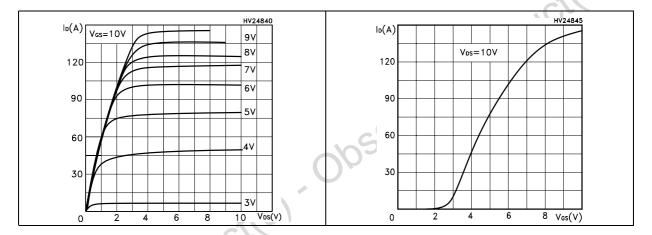


Figure 4. **Output characteristics** 

Figure 5. **Transfer characteristics** 



Transconductance Figure 6.

Downloaded from Arrow.com.

Static drain-source on resistance

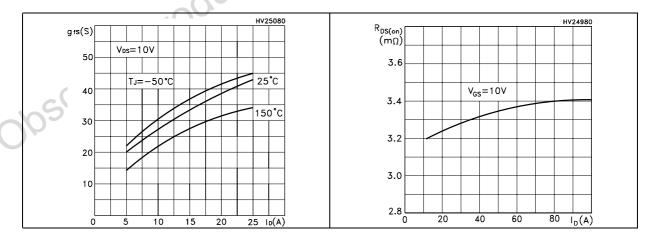


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

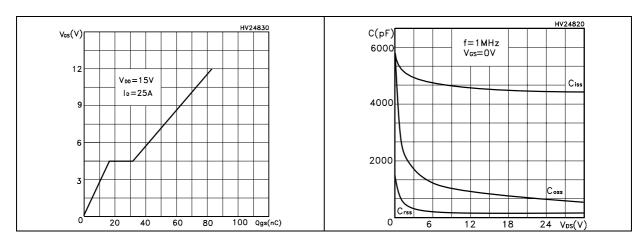


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on resistance vs temperature

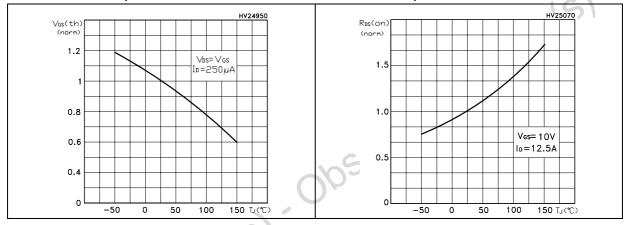
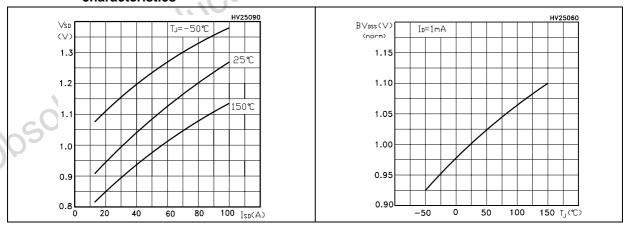


Figure 12. Source-drain diode forward characteristics

Figure 13. Normalized B<sub>VDSS</sub> vs temperature



**577** 

Test circuit STL100NH3LL

## 3 Test circuit

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

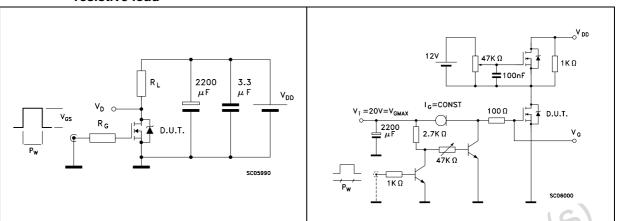


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

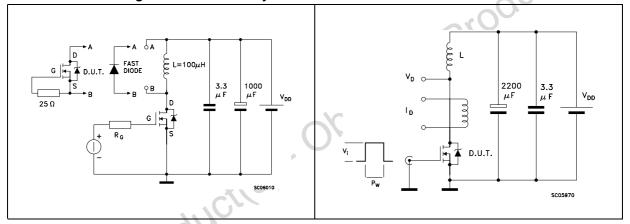
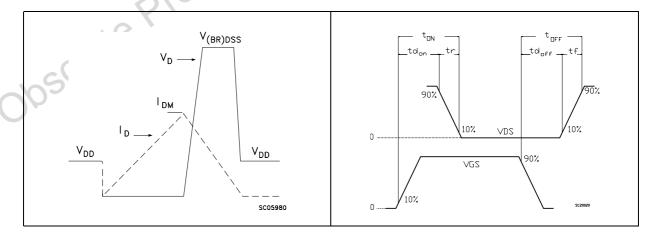


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



## 4 Package mechanical data

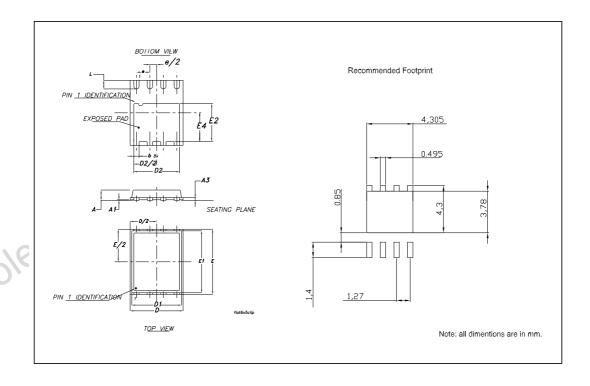
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: <a href="https://www.st.com">www.st.com</a>

Obsolete Product(s). Obsolete Product(s)

**577** 

# PowerFLAT™ (6x5) MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	0.80	0.83	0.93	0.031	0.032	0.036
A1		0.02	0.05		0.0007	0.0019
A3		0.20			0.007	
b	0.35	0.40	0.47	0.013	0.015	0.018
D		5.00			0.196	
D1		4.75			0.187	
D2	4.15	4.20	4.25	0.163	0.165	0.167
Е		6.00			0.236	
E1		5.75			0.226	
E2	3.43	3.48	3.53	0.135	0.137	0.139
E4	2.58	2.63	2.68		0.103	0.105
е		1.27			0.050	
L	0.70	0.80	0.90	0.027	0.031	0.035



57

STL100NH3LL Revision history

# 5 Revision history

Table 9. Document revision history

Date	Date	Revision	Changes
18-Apr-2005	18-Apr-2005	1	First Release
20-Jun-2005	20-Jun-2005	2	Updated mechanical data
22-Jun-2005	22-Jun-2005	3	New Rg value on <i>Table 7</i>
10-Oct-2005	10-Oct-2005	4	Inserted ecopack indication
09-Jan-2006	09-Jan-2006	5	New footprint
08-Mar-2006	08-Mar-2006	6	New template
29-Jun-2006	29-Jun-2006	7	Modified curves, see Figure 2 and Figure 3
04-Sep-2006	04-Sep-2006	8	The document has been reformatted, no content change
04-Jan-2007	04-Jan-2007	9	New updated on Table 2
10-Dec-2007	10-Dec-2007	10	Updated data on Table 4: Avalanche data
20-Mar-2008	20-Mar-2008	11	New V <sub>GS</sub> max. value inserted on <i>Table 4: Avalanche data</i>
Pro	210	Auc'tl	New V <sub>GS</sub> max. value inserted on <i>Table 4: Avalanche data</i>



#### Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2008 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

